

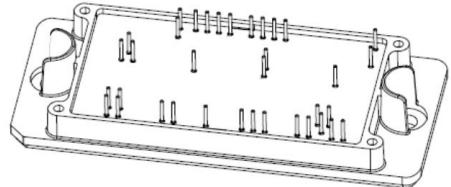
3-Level NPC Inverter Module

1 Description

These Insulated Gate Bipolar Transistor used advanced trench and Fieldstop technology design, provided excellent V_{CEsat} and switching speed ,low gate charge. Which accords with the RoHS standard.

2 Features

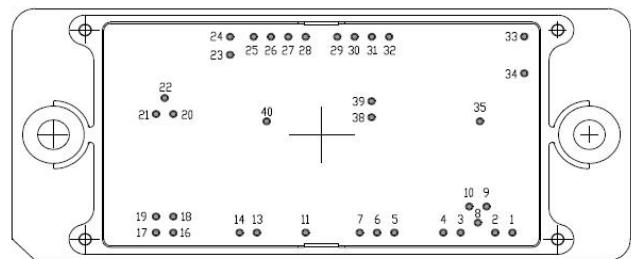
- Higher System Efficiency
- Reduced Cooling Requirements
- Low Conduction Losses Over Temperature
- Neutral Point Clamped Three-Level Inverter Module
- Low Inductive Layout
- Solderable Pins



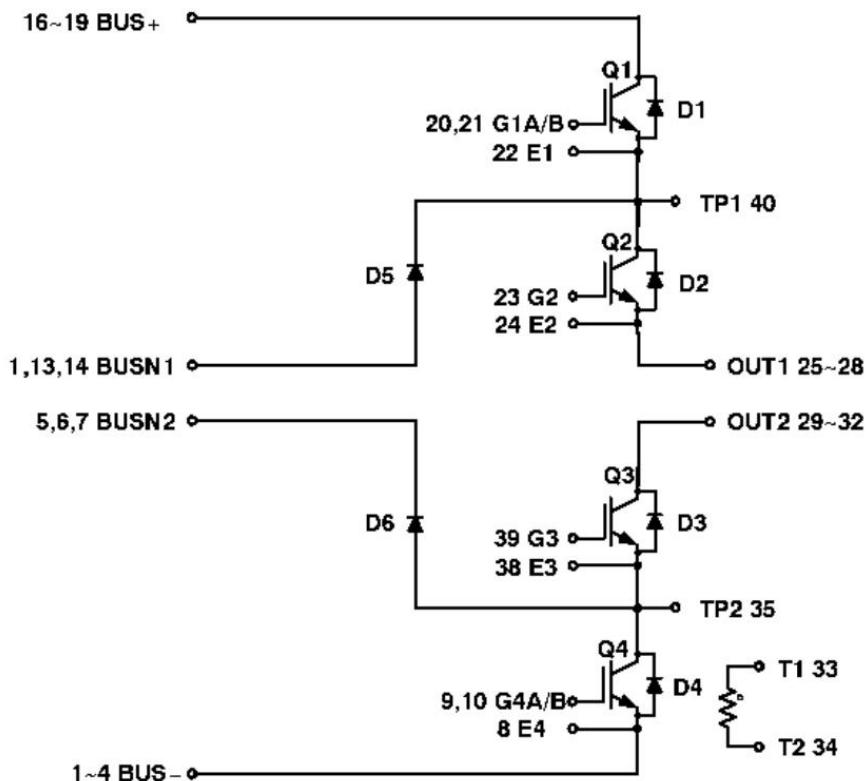
3 Applications

- Solar Inverters
- Uninterruptable Power Supplies Systems

PIN ASSIGNMENTS



4 Equivalent Circuit Schematic



5 Electrical Characteristics

5.1 Absolute Maximum Ratings (Q1|Q4 OUTER IGBT) ($T_J=25^\circ\text{C}$,unless otherwise specified)

Parameter	Symbol	Value	Units
Collector-to-Emitter Voltage	V_{CE}	650	V
Gate-to-Emitter Voltage	V_{GE}	± 23	V
Gate-to-Emitter Voltage _{(Pulsed)^{#1}}	$V_{GE(\text{Pulsed})}$	± 30	V
DC Collector current	I_C	270	A
Pulsed Collector Current	I_{CM}	810	A
Junction Temperature Range	T_{Jmax}	-40~175	$^\circ\text{C}$
Thermal Resistance – Chip-to-Heatsink	R_{thJH}	0.24	$^\circ\text{C}/\text{W}$
Thermal Resistance – Chip-to-Case	R_{thJC}	0.16	$^\circ\text{C}/\text{W}$

5.2 Absolute Maximum Ratings (Q2|Q3 INNER IGBT) ($T_J=25^\circ\text{C}$,unless otherwise specified)

Parameter	Symbol	Value	Units
Collector-to-Emitter Voltage	V_{CE}	650	V
Gate-to-Emitter Voltage	V_{GE}	± 23	V
Gate-to-Emitter Voltage _{(Pulsed)^{#1}}	$V_{GE(\text{Pulsed})}$	± 30	V
DC Collector current	I_C	293	A
Pulsed Collector Current	I_{CM}	880	A
Junction Temperature Range	T_{Jmax}	-40~175	$^\circ\text{C}$
Thermal Resistance – Chip-to-Heatsink	R_{thJH}	0.28	$^\circ\text{C}/\text{W}$
Thermal Resistance – Chip-to-Case	R_{thJC}	0.16	$^\circ\text{C}/\text{W}$

#¹ $V_{GE(\text{Pulsed})}$. Pulse width 5uS

5.3 Absolute Maximum Ratings (D1~D4 Diode) ($T_J=25^\circ\text{C}$,unless otherwise specified)

Parameter	Symbol	Value	Units
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Average Rectified Forward Current	$I_{F(AV)}$	188	A
Repetitive Peak Forward Current	I_{FRM}	563	A
Junction Temperature Range	T_{Jmax}	-40~175	$^\circ\text{C}$
Thermal Resistance – Chip-to-Heatsink	R_{thJH}	0.41	$^\circ\text{C}/\text{W}$
Thermal Resistance – Chip-to-Case	R_{thJC}	0.32	$^\circ\text{C}/\text{W}$

5.4 Absolute Maximum Ratings (D5~D6 Diode) ($T_J=25^\circ\text{C}$,unless otherwise specified)

Parameter	Symbol	Value	Units
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Average Rectified Forward Current	$I_{F(AV)}$	230	A
Repetitive Peak Forward Current	I_{FRM}	690	A
I^2t -value@ $VR = 0 \text{ V}$, $tP = 10 \text{ ms}$, $Tvj = 150^\circ\text{C}$	I^2t	9800	A^2s
Junction Temperature Range	T_{Jmax}	-40~175	$^\circ\text{C}$
Thermal Resistance – Chip-to-Heatsink	R_{thJH}	0.29	$^\circ\text{C}/\text{W}$
Thermal Resistance – Chip-to-Case	R_{thJC}	0.19	$^\circ\text{C}/\text{W}$

5.5 RECOMMENDED TEMPERATURE (IGBT Module)

Parameter	Symbol	Value	Units
Storage Temperature	T_{stg}	-40~125	$^\circ\text{C}$
Operating Temperature	T_{op}	-40~150	$^\circ\text{C}$

5.6 Thermal Characteristics (IGBT Module)

Parameter	Symbol	Value	Units
Isolation Test Voltage, $t = 1 \text{ s}, 50 \text{ Hz}$	V_{ISO}	4000	V
Stray Inductance	L_{CE}	17	nH
Mounting Torque(Screw:M5)	M	3~5	N.m
Flatness of base plate		0.3	mm
Weight		176.5	g
Clearance	terminal to heatsink	12.7	
Creepage distance	terminal to heatsink	12.7	
CTI		≥ 600	
RTI		130	°C

5.7 Electrical Characteristics (Q1\Q4 IGBT) ($T_j=25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Units
			Min	Typ	Max	
Static Characteristics						
Collector-to-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CES}}$	$I_C=250\mu\text{A}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$	650	--	--	V
Collector-to-Emitter Leakage	I_{CES}	$V_{CE}=650\text{V}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$	--	--	100	μA
Gate-to-Emitter Leakage Current	I_{GES}	$V_{GE}=\pm 23\text{V}, V_{CE}=0\text{V}, T_j=25^\circ\text{C}$	--	--	± 100	nA
Gate Threshold Voltage	$V_{GE(\text{th})}$	$V_{CE}=V_{GE}, I_C=4.0\text{mA}$	3.2	3.8	4.4	V
Collector-emitter saturation voltage	V_{CEsat}	$V_{GE}=15\text{V}, I_C=450\text{A}, T_j=25^\circ\text{C}$	--	1.6	2.2	V
		$V_{GE}=15\text{V}, I_C=450\text{A}, T_j=150^\circ\text{C}$	--	1.85	-	V
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{CE}=20\text{V}, V_{GE}=0\text{V}, f=10\text{KHz}, T_a=25^\circ\text{C}$	--	24054	--	pF
Output Capacitance	C_{oss}		--	1942	--	
Reverse Transfer Capacitance	C_{rss}		--	140	--	
IGBT Characteristics						
Turn-on delay time	$t_{\text{d(on)}}$	$V_{GE} = -7 \text{ V} / +15 \text{ V}$ $V_{CE} = 400 \text{ V}$ $I_C = 150 \text{ A}$ $R_{\text{Gon}} = 9.4 \Omega$ $R_{\text{Goff}} = 15.7 \Omega$ $T_j = 25^\circ\text{C}$	--	75	--	nS
Rise time	t_r		--	33	--	nS
Turn-off delay time	$t_{\text{d(off)}}$		--	757	--	nS
Fall time	t_f		--	44	--	nS
Turn-on energy	E_{on}		--	4.7	--	mJ
Turn-off energy	E_{off}		--	2.6	--	mJ
Total switching energy	E_{ts}		--	7.3	--	mJ
Turn-on delay time	$t_{\text{d(on)}}$		--	58	--	nS
Rise time	t_r		--	38	--	nS
Turn-off delay time	$t_{\text{d(off)}}$		--	804	--	nS
Fall time	t_f		--	54	--	nS
Turn-on energy	E_{on}	$R_{\text{Gon}} = 9.4 \Omega$ $R_{\text{Goff}} = 15.7 \Omega$ $T_j = 150^\circ\text{C}$	--	7.2	--	mJ
Turn-off energy	E_{off}		--	3.3	--	mJ
Total switching energy	E_{ts}		--	10.5	--	mJ
Gate charge	Q_g		--	1.6	--	uC

5.8 Electrical Characteristics (D5/D6 Diode)(Tc=25°C, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Units
			Min	Typ	Max	
Diode forward voltage	V _F	I _F =450A, T _j =25°C	--	1.65	2.05	V
		I _F =450A, T _j =150°C	--	1.75	--	V
Diode reverse recovery time	t _{rr}	V _{GE} = -7 V / +15 V V _{CE} = 400 V, I _C = 150 A	--	173	--	ns
Diode peak reverse recovery current	I _{rrm}		--	120	--	A
Diode reverse recovery charge	Q _{rr}	R _{Gon} = 9.4 Ω, R _{Goff} = 15.7 Ω T _j = 25°C	--	8.68	--	uC
Reverse Recovery Energy	E _{RR}		--	1.94	--	mJ
Diode reverse recovery time	t _{rr}	V _{GE} = -7 V / +15 V V _{CE} = 400 V, I _C = 150 A	--	215	--	ns
Diode peak reverse recovery current	I _{rrm}		--	184	--	A
Diode reverse recovery charge	Q _{rr}	R _{Gon} = 9.4 Ω, R _{Goff} = 15.7 Ω T _j = 150°C	--	20.4	--	uC
Reverse Recovery Energy	E _{RR}		--	4.55	--	mJ

5.9 Electrical Characteristics (Q2\Q3 IGBT) (Tj=25°C, unless otherwise specified)

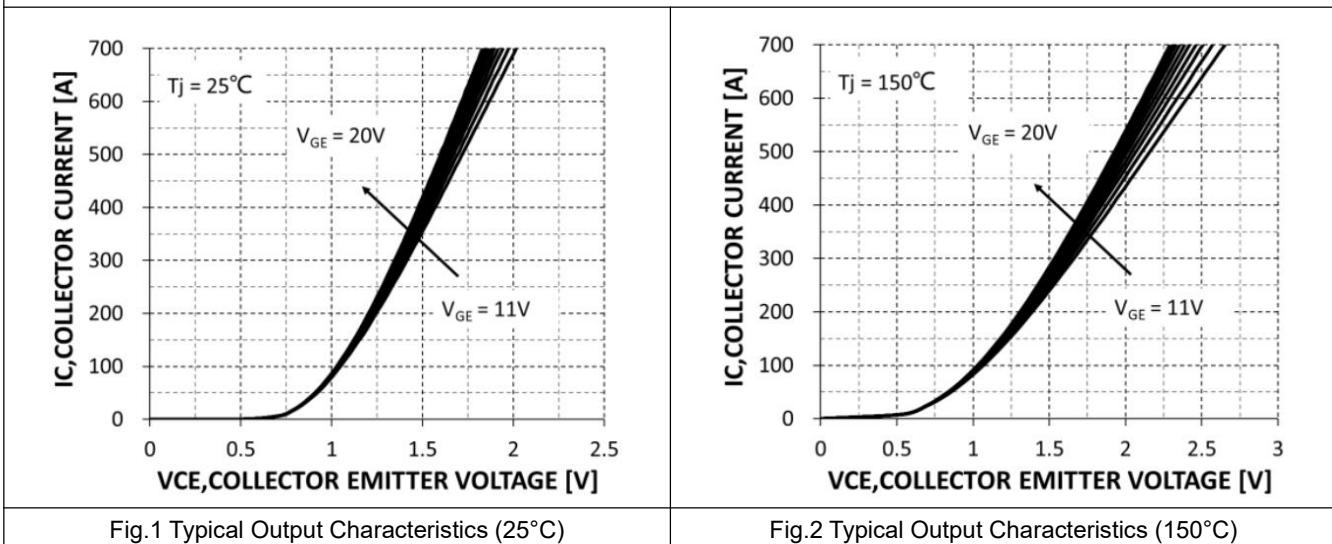
Parameter	Symbol	Conditions	Value			Units
			Min	Typ	Max	
Static Characteristics						
Collector-to-Emitter Breakdown Voltage	V _{(BR)CES}	I _C =250μA,V _{GE} =0V,T _j =25°C	650	--	--	V
Collector-to-Emitter Leakage	I _{CES}	V _{CE} =650V,V _{GE} =0V,T _j =25°C	--	--	100	μA
Gate-to-Emitter Leakage Current	I _{GES}	V _{GE} =±23V,V _{CE} =0V,T _j =25°C	--	--	±100	nA
Gate Threshold Voltage	V _{GE(th)}	V _{CE} =V _{GE} ,I _C =4.0mA	4.2	4.85	5.4	V
Collector-emitter saturation voltage	V _{CEsat}	V _{GE} =15V,I _C =450A,T _j =25°C	--	1.28	1.8	V
		V _{GE} =15V,I _C =450A,T _j =150°C	--	1.45	-	V
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{CE} =20V,V _{GE} =0V, f=10KHz,T _a =25°C	--	46942	--	pF
Output Capacitance	C _{oss}		--	982	--	
Reverse Transfer Capacitance	C _{rss}		--	263	--	
IGBT Characteristics						
Turn-on delay time	t _{d(on)}	V _{GE} = -7 V / +15 V V _{CE} = 400 V I _C = 150 A R _{Gon} = 40 Ω R _{Goff} = 40 Ω T _j = 25°C	--	826	--	nS
Rise time	t _r		--	149	--	nS
Turn-off delay time	t _{d(off)}		--	3790	--	nS
Fall time	t _f		--	118	--	nS
Turn-on energy	E _{on}		--	15.9	--	mJ
Turn-off energy	E _{off}		--	8.8	--	mJ
Total switching energy	E _{ts}		--	24.7	--	mJ
Turn-on delay time	t _{d(on)}	V _{GE} = -7 V / +15 V V _{CE} = 400 V I _C = 150 A R _{Gon} = 40 Ω R _{Goff} = 40 Ω T _j = 150°C	--	689	--	nS
Rise time	t _r		--	180	--	nS
Turn-off delay time	t _{d(off)}		--	4167	--	nS
Fall time	t _f		--	108	--	nS
Turn-on energy	E _{on}		--	18.75	--	mJ
Turn-off energy	E _{off}		--	9.3	--	mJ
Total switching energy	E _{ts}		--	28.05	--	mJ
Gate charge	Q _g	V _{CE} =480V, V _{GE} =±15V	--	3.7	--	uC

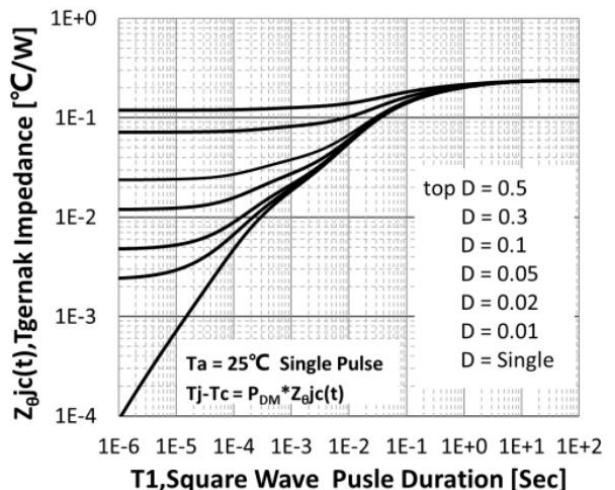
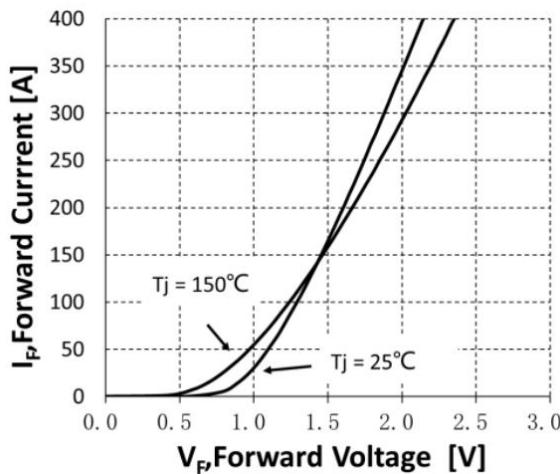
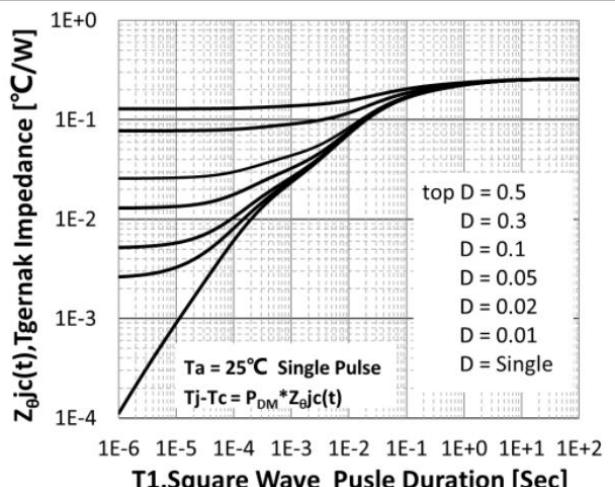
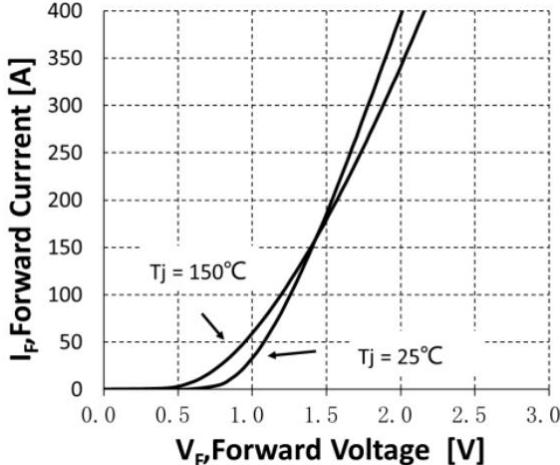
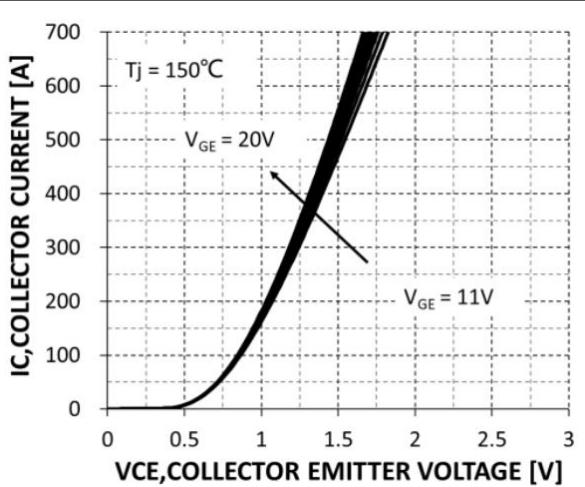
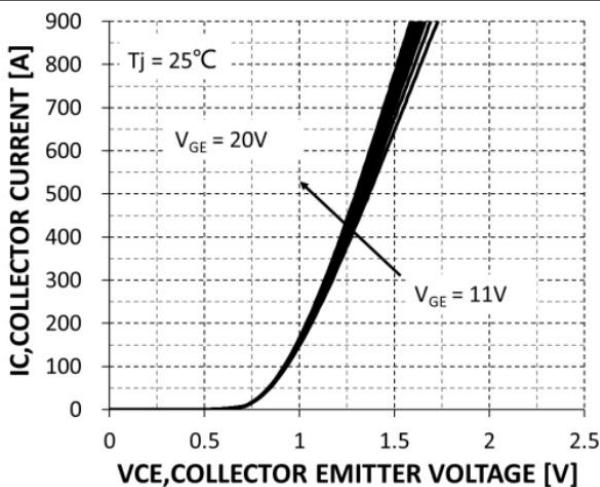
5.10 Electrical Characteristics (D1~D4 Diode)(Tc=25°C, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Units
			Min	Typ	Max	
Diode forward voltage	V_F	$I_F=100A, T_j=25^\circ C$	--	1.23	1.65	V
		$I_F=100A, T_j=150^\circ C$	--	1.18	--	V
Diode reverse recovery time	t_{rr}	$V_{GE} = -7 V / +15 V$ $V_{CE} = 400 V, I_C = 150 A$	--	363	--	ns
Diode peak reverse recovery current	I_{rrm}		--	43.3	--	A
Diode reverse recovery charge	Q_{rr}	$R_{Gon} = 40 \Omega, R_{Goff} = 40 \Omega$ $T_j = 25^\circ C$	--	6.48	--	uC
Reverse Recovery Energy	E_{RR}		--	1.1	--	mJ
Diode reverse recovery time	t_{rr}	$V_{GE} = -7 V / +15 V$ $V_{CE} = 400 V, I_C = 150 A$	--	436	--	ns
Diode peak reverse recovery current	I_{rrm}		--	48.1	--	A
Diode reverse recovery charge	Q_{rr}	$R_{Gon} = 40 \Omega, R_{Goff} = 40 \Omega$ $T_j = 150^\circ C$	--	10.6	--	uC
Reverse Recovery Energy	E_{RR}		--	1.78	--	mJ

5.11 Electrical Characteristics (NTC)(Tc=25°C, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Units
			Min	Typ	Max	
Rated Resistance	R_{25}	$T_c=25^\circ C$	--	22	--	kΩ
B-value	$B_{25/50}$	B (25/50), tolerance $\pm 3\%$	--	3950	--	k
B-value	$B_{25/100}$	B (25/100), tolerance $\pm 3\%$	--	3998	--	k
Deviation of R100	$\Delta R/R$	$T_c = 100^\circ C, R100 = 493 \Omega$	-5	--	+5	%
Pow er Dissipation	P_{25}	TNTC = 25°C	--	--	20	mW

6 Typical Characteristic Curves
IGBT Q1, Q4 And DIODE D1, D4



IGBT Q2, Q3 And DIODE D2, D3


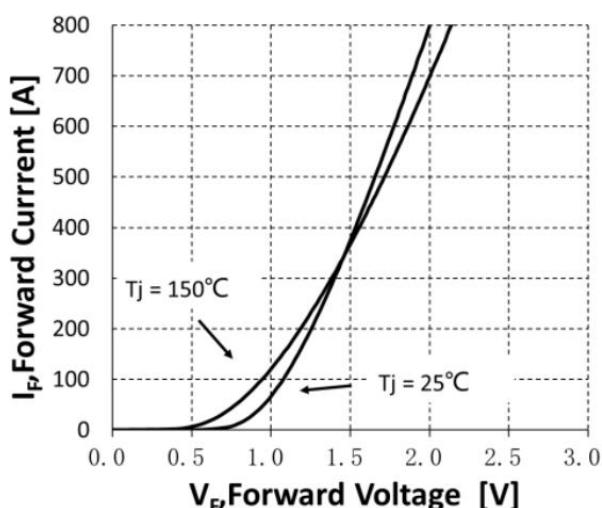
DIODE D5, D6


Fig.9 Diode Forward Characteristics

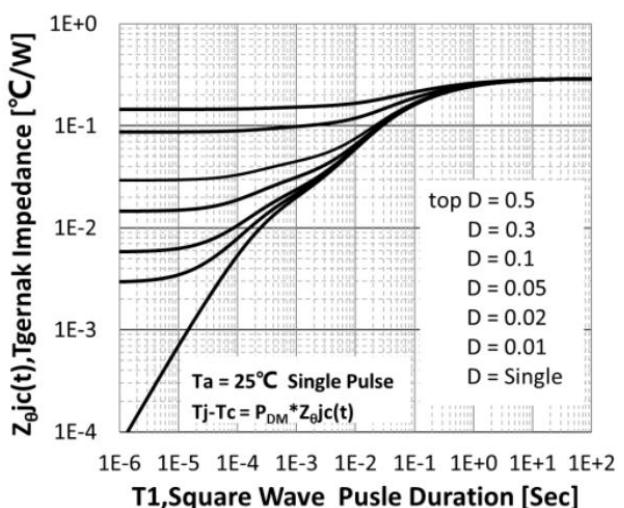


Fig.10 Transient Thermal Impedance(D5,D6)

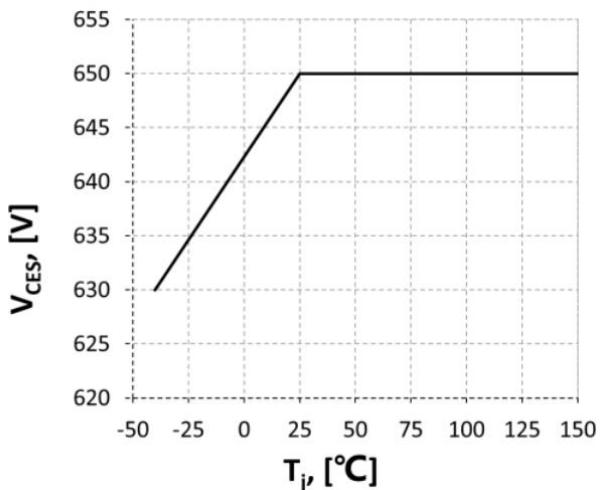


Fig.11 maximum allowed collector-emitter voltage(D5,D6)

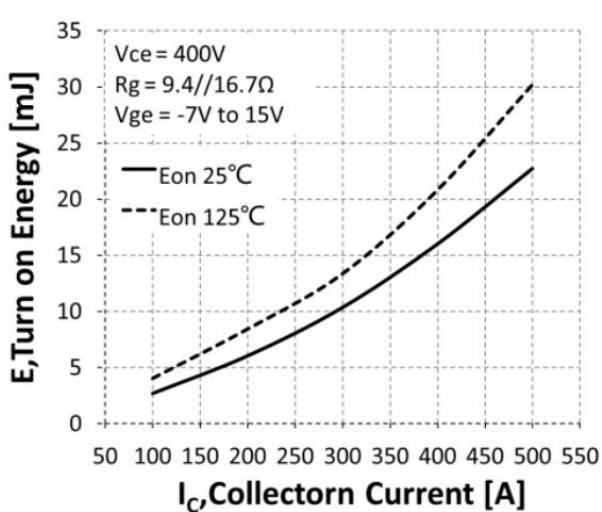
IGBT Q1, Q4 And DIODE D5, D6


Fig.12 Typical Switching Loss Eon vs. IC

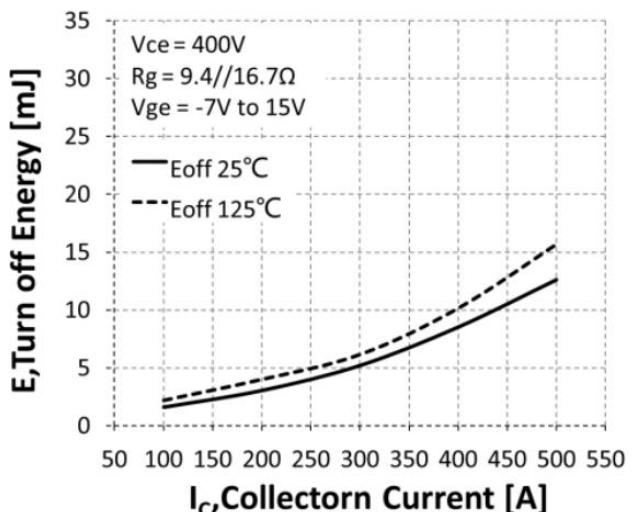


Fig.13 Typical Switching Loss Eoff vs. IC

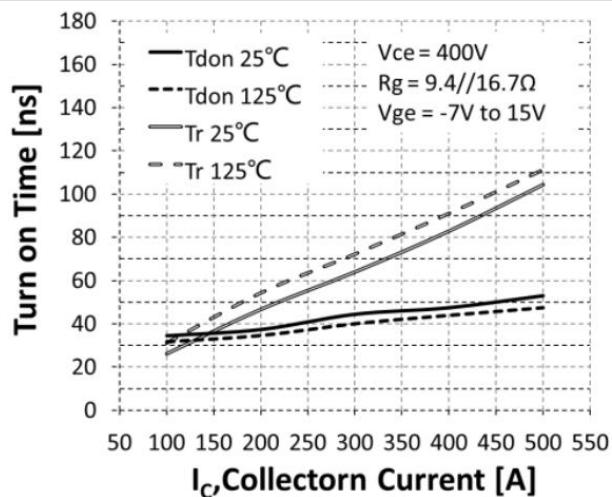


Fig.14 Typical Switching Time Ton vs. IC

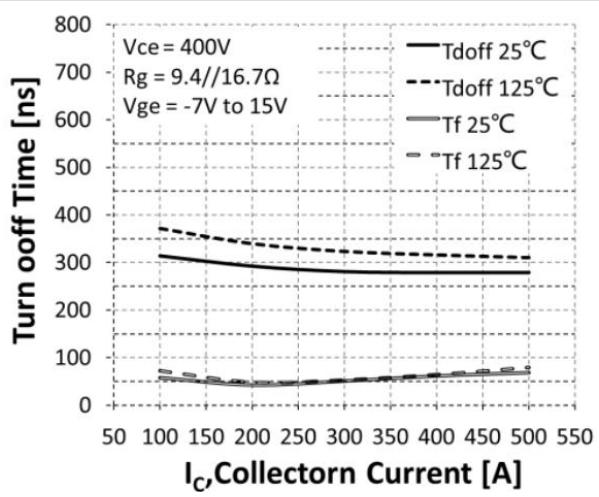


Fig.15 Typical Switching Time Toff vs. IC

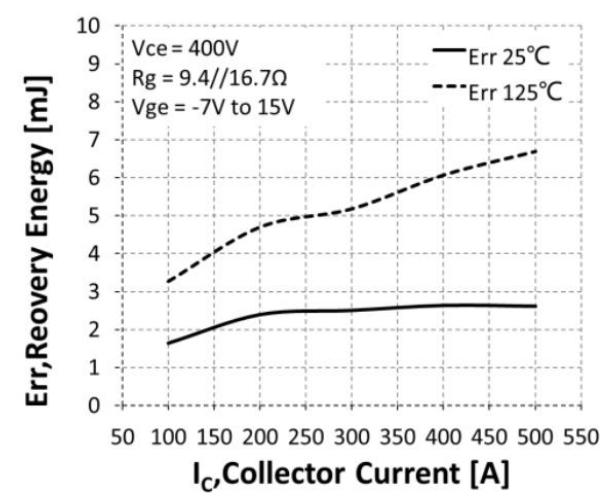


Fig.16 Typical Recovery Energy vs. IC

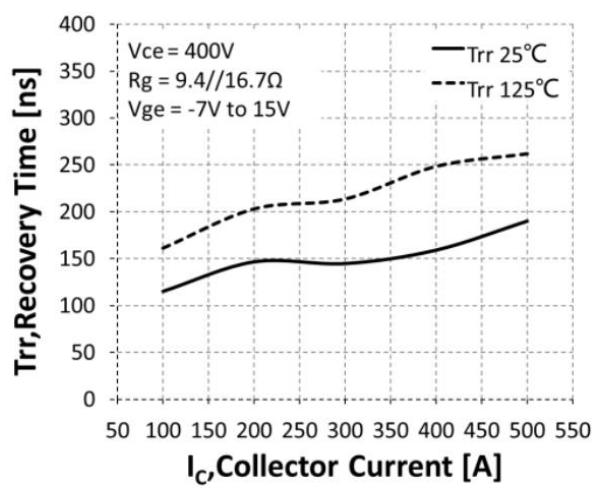


Fig.17 Typical Recovery Time vs. IC

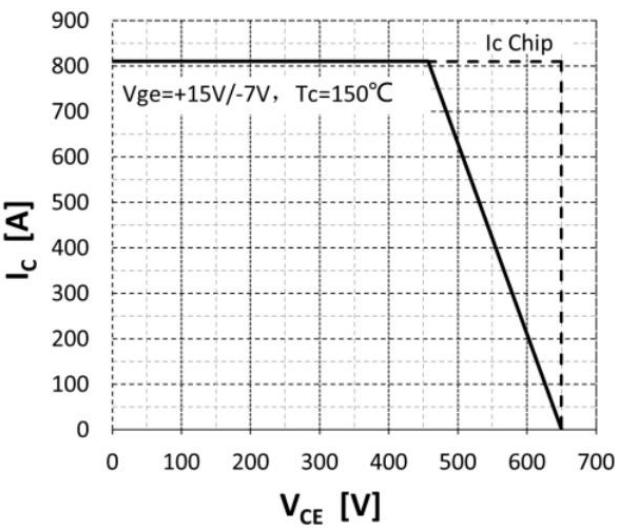


Fig.18 RBSOA(Q1,Q4)

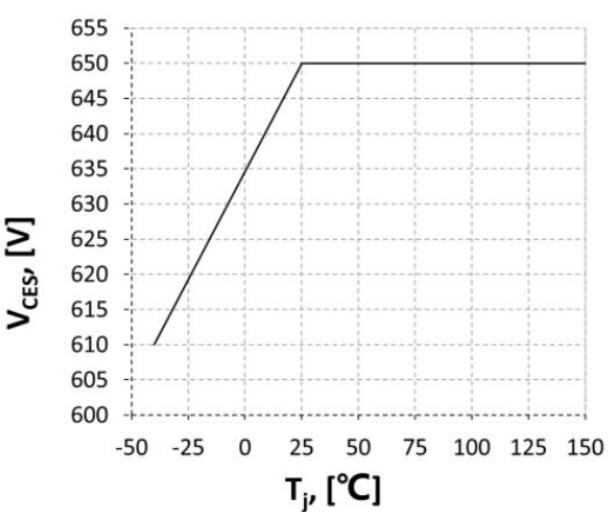


Fig.19 maximum allowed collector-emitter voltage (Q1,Q4)

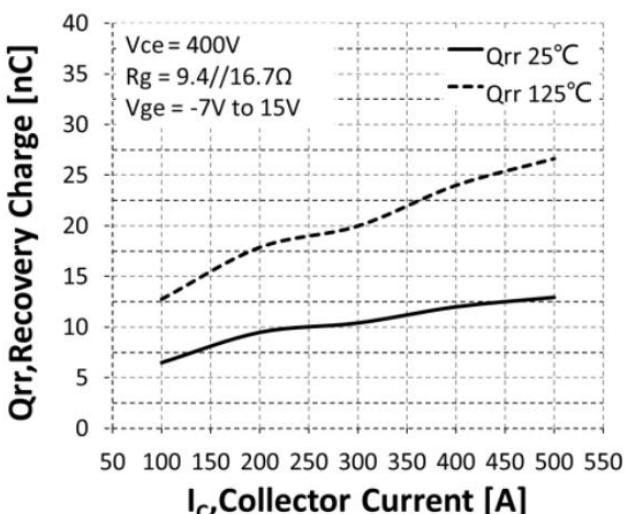
IGBT Q1, Q4 And DIODE D5, D6 (continued)


Fig.20 Typical Recovery Charge vs. IC

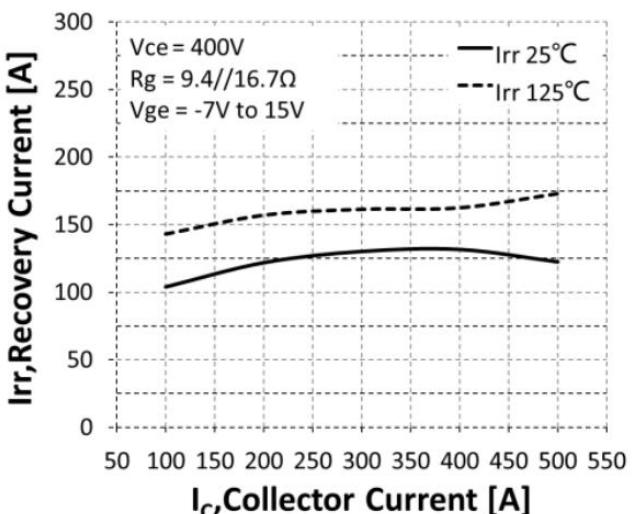
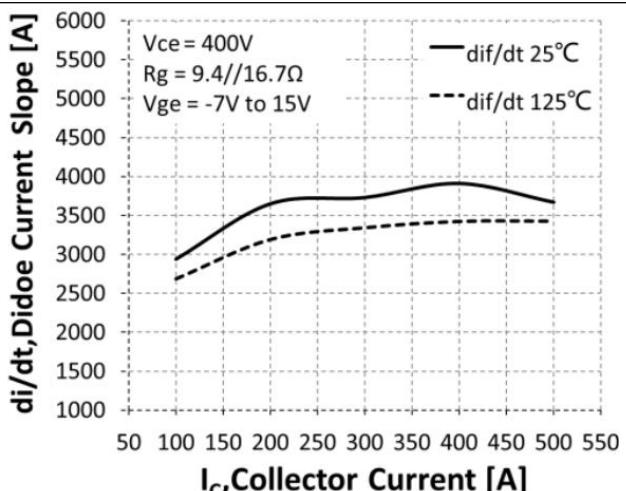
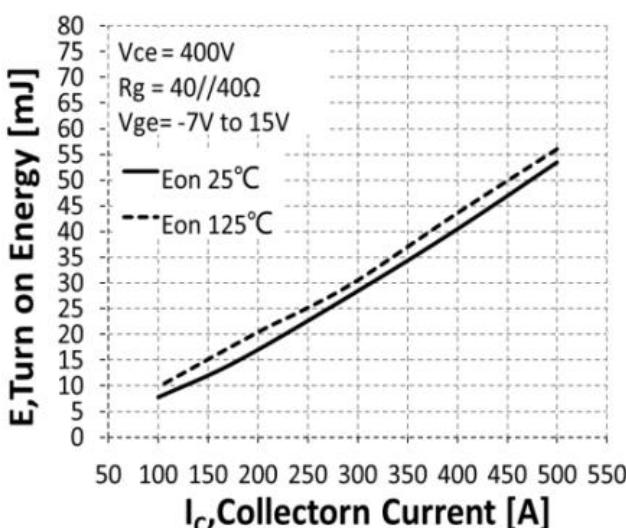
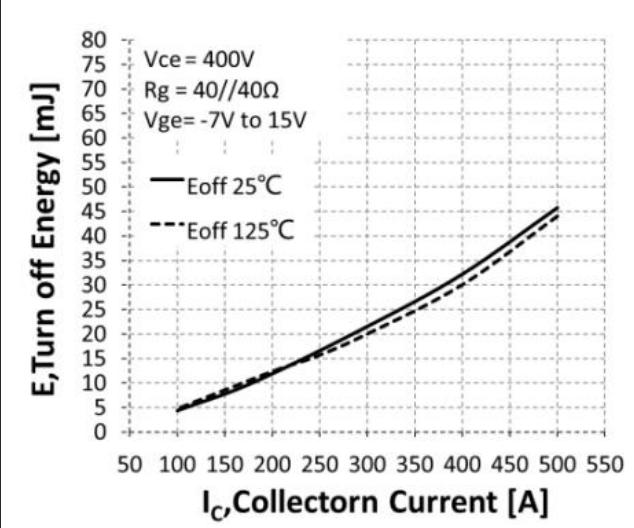
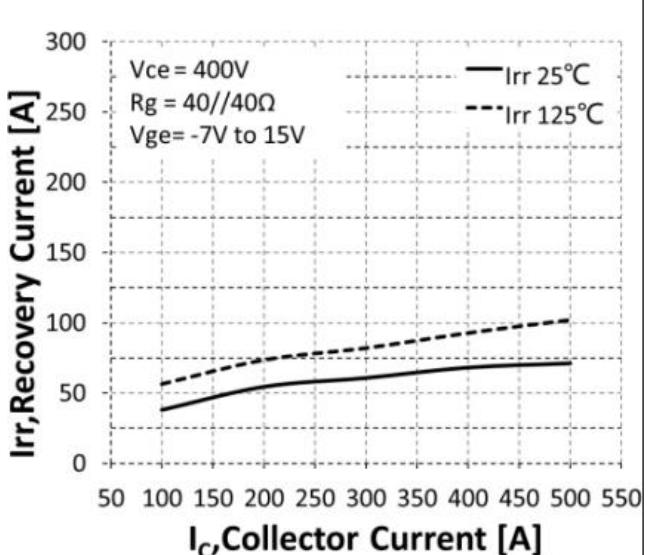
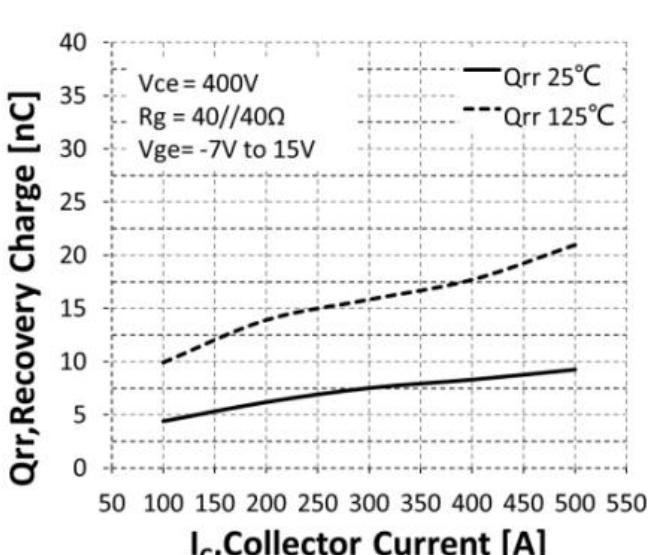
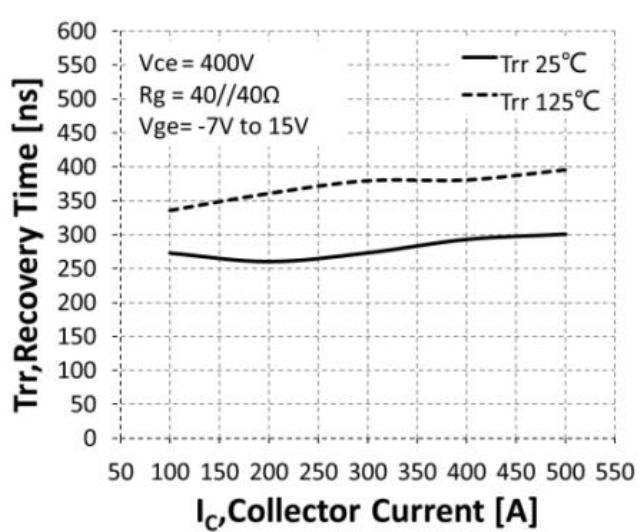
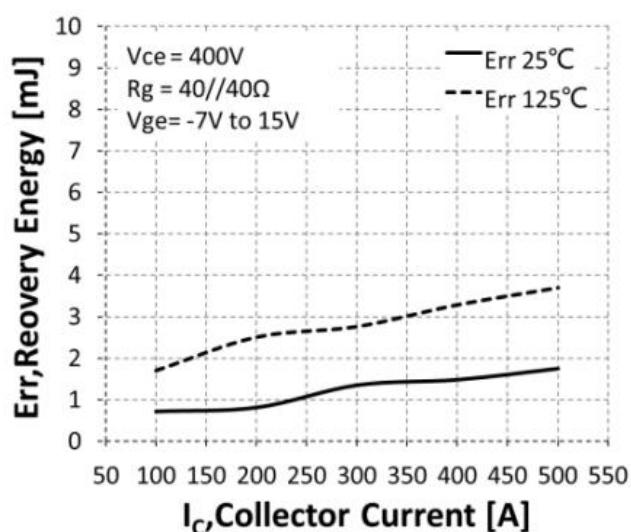
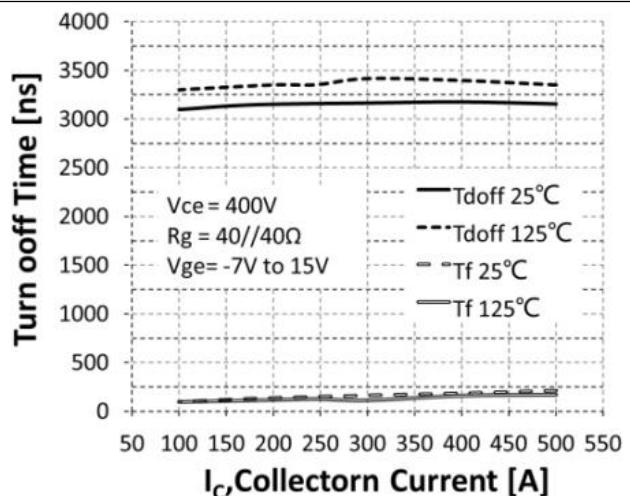
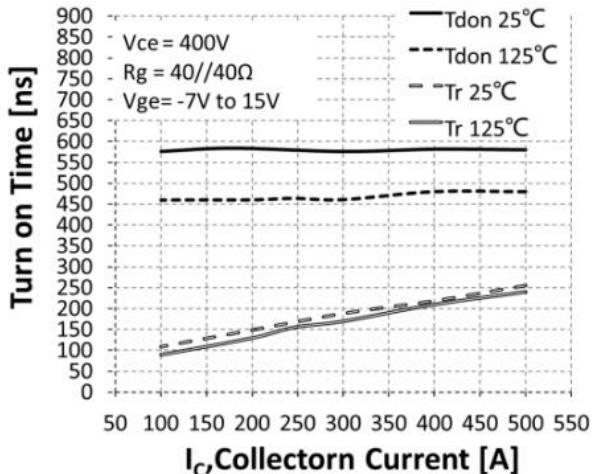


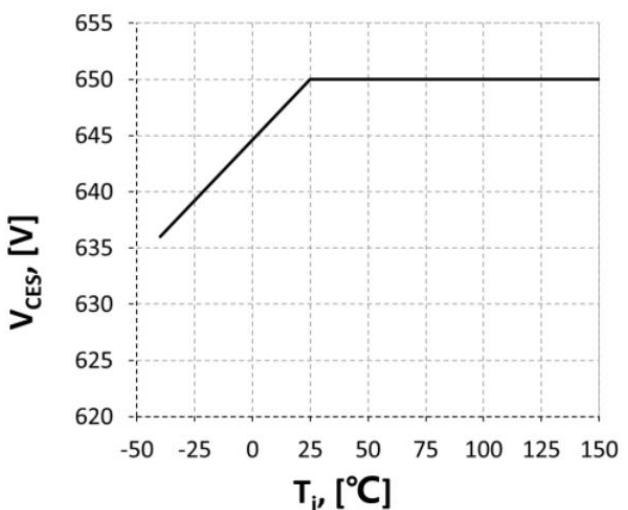
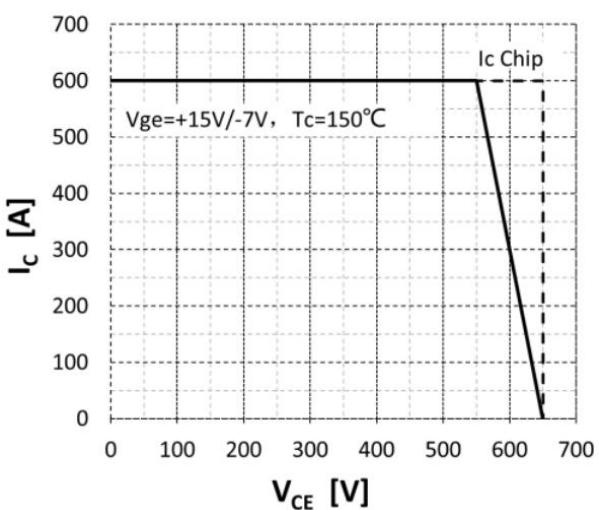
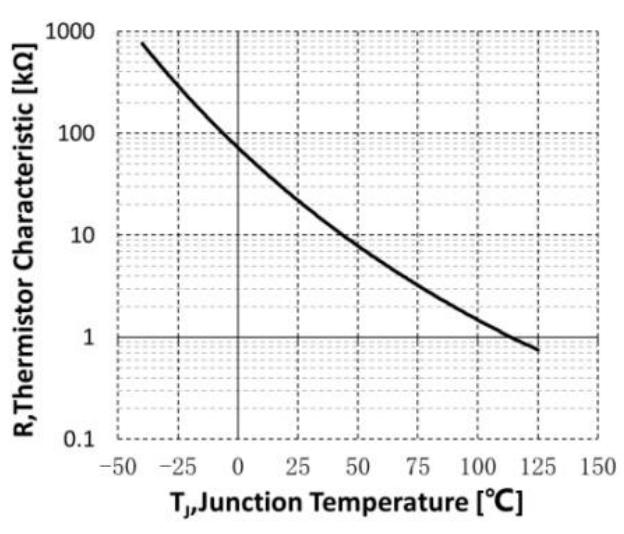
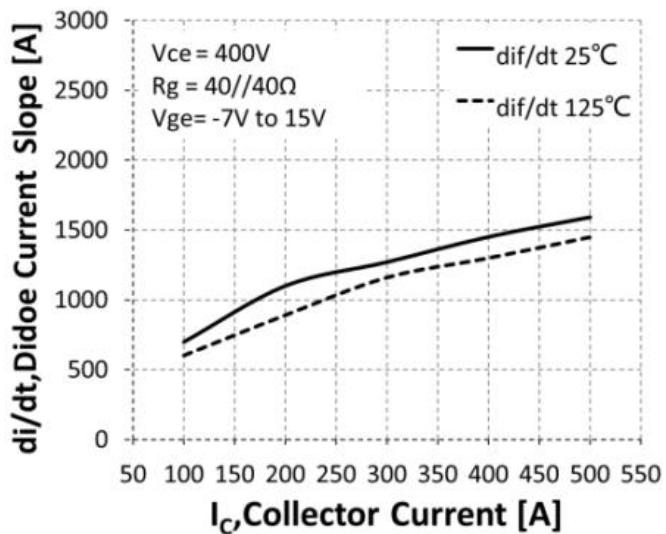
Fig.21 Typical Recovery Current vs. IC


 Fig.22 Typical di/dt vs. IC

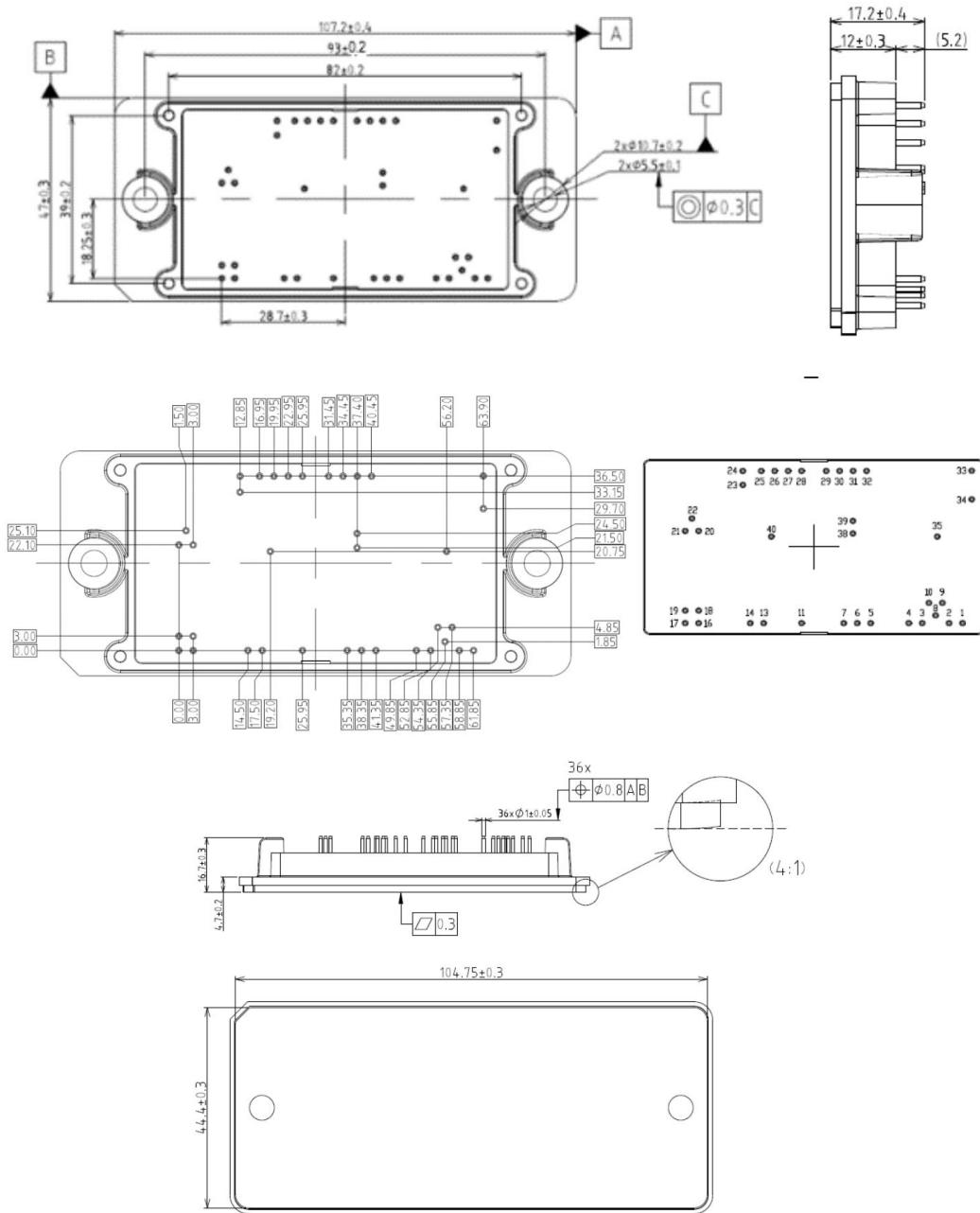
--

IGBT Q2, Q3 And DIODE D1, D4

 Fig.23 Typical Switching Loss E_{on} vs. IC

 Fig.24 Typical Switching Loss E_{off} vs. IC





7 Dimensions



8 Attentions

- Jiangsu Donghai Semiconductor Technology CO.,LTD. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
- It is the responsibility of the purchaser for any failure or failure of any semiconductor product under certain conditions. It is the responsibility of the purchaser to comply with safety standards and to take safety measures in the system design and machine manufacturing of Donghai products in order to avoid potential risk of failure. Injury or property damage.
- Product promotion is endless, our company will be dedicated to provide customers with better products.

9 Appendix

Revision history:

Date	REV.	Description	Page
2023.3.1	1.0	Original	
2023.3.22	1.1	Add product name	All
		Add PIN Assignments	1 Page
2023.3.23	1.2	Adding Curves	5~10 Page
		Modify some parameters	All
		Revise Dimensions	10Page
2023.5.8	1.3	Add DIODE (D5,D6) I^2t value parameter	2 Page
		Adjust RECOMMENDED TEMPERATURE sequence	2 Page
		Add Thermal Characteristics parameter	3 Page
		Add RBSOA (Q1,Q2,Q3,Q4) curve	8,11Page
		Add maximum allowed collector-emitter voltage (Q1,Q2,Q3,Q4, D5,D6) curve	7,8,11Page
2023.5.25	1.4	Modify the VGE voltage to $\pm 23V$ (Original $\pm 20V$)	2, 3, 4Page
2023.6.7	1.5	Add $V_{GE(\text{Pulsed})}$ voltage	2 Page